RECEIVED CENTRAL FAX CENTER

Attorney's Docket 081468-0313645 Client Reference: P-2058.000-US

OCT 0 6 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT APPLICATION of:

Confirmation Number: 3594

HOEKS ET AL.

Application No.: 10/643,167

Group Art Unit: 2851

Examiner: H. Nguyen

Title: CHUCK, LITHOGRAPHIC APPARATUS AND DEVICE MANUFACTURING

METHOD

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

CERTIFICATION OF FACSIMILE TRANSMISSION UNDER 37 C.F.R. §1.8

I hereby certify that the following papers are being facsimile transmitted to the Patent and Trademark Office at (571) 273-8300 on the date shown below:

Statement of the Substance of the Interview

WINTHROP SHAW PITTMAN LLP

Jean-Pal Reg. No.

Date: October 6, 2005

P.O. Box 10500 McLean, VA 22102 Telephone: (703) 905-2000 Facsimile: (703) 905-2500

703-905-2500

T-312 P.002/003 F-231

Attorney Docket: 0081468-0305463 Client Reference: P-0347.010-US

RECEIVED **CENTRAL FAX CENTER**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

OCT 0 6 2005

In re PATENT APPLICATION of:

Confirmation Number: 3594

HOEKS ET AL.

Application No.: 10/643,167

Group Art Unit: 2851

Filed: August 19, 2003

Examiner: H. Nguyen

Title: CHUCK, LITHOGRAPHIC APPARATUS AND DEVICE MANUFACTURING

METHOD

October 6, 2005

STATEMENT OF THE SUBSTANCE OF THE INTERVIEW

United States Patent and Trademark Office Customer Service Window Randolph Building 401 Dulany Street Alexandria, VA 22314

Sir:

Attached to the Notice of Allowability, mailed on September 13, 2005, was an Interview Summary Record summarizing a telephone interview between the undersigned and the Examiner on August 28, 2005. The Interview Summary Record requires the Applicant to file a statement memorializing the substance of the interview. In reply, Applicant confirms the substance of the Examiner's summary of the interview although Applicant believes the interview was held on August 29, 2005. During the interview, independent claim 1 was discussed. Applicant identified how Logan et al. and/or Tamagawa et al. fail to disclose, teach or suggest all the features recited by claim 1, namely, among other things, a plurality of pins having a conductive layer on the surface in contact with the object, the conductive layer having a specific resistivity less than 10 Ohm m. In particular, Applicant argued that neither Tamagawa et al. nor Logan et al. provide any disclosure, suggestion, or teaching of using a low resistivity layer on the surface in contact with the object. Use of a conductive layer having a specific resistivity less than 10 Ohm m on the surface of a plurality of pins in contact with the object would be counter to the teachings of Tamagawa et al. and Logan et al., which disclose increasing or having high holding power of an electrostatic chuck through the Johnsen-Rahbek effect. The only low resistivity and conductive layers disclosed in Logan et al. and Tamagawa et al. are not configured to be in contact with the object.

HOEKS ET AL. - 10/643,167 Client/Matter: 081468-0305463

Applicants believe that this Statement is fully responsive to the requirement in the Interview Summary Record.

Respectfully submitted,

PILESBURK WINTEROP SHAW PITTMAN LLP

Jean-Paul G. Hoffman Reg. No. 42668

Tel. No. (70%) 905-2094 Fax No. (703) 905-2500

Date: October 6, 2005 P.O. Box 10500 McLean, VA 22102 (703) 905-2000